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PTO/SB/21 (08-00)

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		Application Number	10/618,282
		Filing Date	July 9, 2003
		First Named Inventor	Sorrells, Martin
		Group Art Unit	
		Examiner Name	
Total Number of Pages in This Submission	12+	Attorney Docket Number	AES 03-002

ENCLOSURES (check all that apply)

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Firm or Individual name	PD Holdings (USA), Inc. Patrick H. McCollum
Signature	<i>Patrick H. McCollum</i>
Date	22 Oct 03

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I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to: Commissioner for Patents, Washington, DC 20231 on this date:

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PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANTS: Martin Sorrells
U.S. APPLICATION NUMBER: 10/618,282
U.S. FILING DATE: July 9, 2003
ATTORNEY DOCKET NO: AES 03-002
TITLE OF THE INVENTION: Compensation Ensemble Crystal Oscillator for Use
in a Well Borehole System

GROUP ART UNIT

Assistant Commissioner for Patents
Mail Stop DD; P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Dear Sirs:

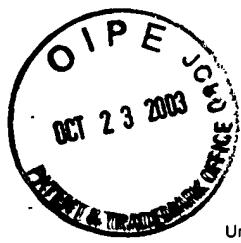
In accordance with §§ 1.56, 1.97 and 1.98 of Title 37 of the Code of Federal Regulations and pursuant to Applicant's duty of candor and good faith toward the United States Patent and Trademark Office, applicant discloses the following information items which constitute the most relevant information items of which persons substantively involved in the present application are aware. Pursuant to 37 CFR § 1.97(h) the information disclosed shall not be construed to be an admission of materiality to patentability.

Seven (7) U.S. Patents, three (3) Foreign Patents and eighty-nine (89) technical papers, articles and tutorials that relate to this invention are listed on the enclosed PTO/SB/08A and copies of these items are enclosed pursuant to § 1.98.

Respectively Submitted,

Patrick H. McCollum
Registration No. 29,410
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Houston, TX 77060
281-260-5616 Telephone
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Attorney for Applicant



PTO/SB/08A (10-01)

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Substitute for form 1449A/PTO				Complaint if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Application Number	10/618,269
(use as many sheets as necessary)				Filing Date	July 9, 2003
				First Named Inventor	Sorrells, Martin
				Art Unit	
				Examiner Name	
Sheet	01	of	10	Attorney Docket Number	AES 03-002

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS					
Examiner Initials	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Country Code ³ -Number ⁴ - Kind Code ⁵ (if known)			
		EP0716319A2 EP1002934A2 WO98/17894	06-12-1996 05-24-2000 04-30-1998	Petersen & Heggernes Eaton, Michael MacDonald et al.	

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¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 02 of 10

Complete if Known

Application Number	10/618,282
Filing Date	July 9, 2003
First Named Inventor	Sorrells, Martin
Group Art Unit	
Examiner Name	
Attorney Docket Number	AES 03-002

OTHER PRIOR ART -- NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T ²
		<p>Raymond L. Filler, The Acceleration Sensitivity of quartz Crystal Oscillators: A Review IEEE Transactions on Ultrasonics, Ferroelectrics, and Frequency Control Vol 35, No. 3, May 1988</p> <p>R.C. Smythe, Acceleration Effects in Crystal Filters: A Tutorial IEEE Transactions on Ultrasonics, Ferroelectrics, and Frequency Control Vol 39, No. 3, May 1992</p> <p>Roger W. Ward, The Constants of Alpha Quartz 14th Piezoelectric Devices Conference and Exhibits, September 15-17, 1992</p> <p>John R. Vig, Introduction to Quartz Frequency Standards Army Reserach Laboratory; SLCET-TR-91-1 (Rev. 1), October, 1992</p> <p>Arthur Ballato, Piezoelectricity: Venerable Effect, Modern Thrusts Army Research Laboratory; ARL-TR-70, August, 1994</p> <p>Arthur Ballato, Doubly Rotated Thickness Mode Plate Vibrators US Army Electronics Technology & Devices Laboratory (reprinted from Physical Acoustics Vol XIII, 1977, Academic Press Inc.)</p> <p>John R. Vig, and Thrygve R. Meeker, The Aging of Bulk Acoustic Wave Resonators, Filters and Oscillators; US Army Communications-Electronics Command, 45th Annual Symposium on Frequency Control, pp. 77-101, 1991</p> <p>John A. Kustes and John R. Vig, Hysteresis in Quartz Resonators: A Review IEEE Transactions of Ultrasonics, Ferroelectrics, and Frequency Control, Vol 39, No. 3, May 1991</p> <p>Errol P. Eernisse, Roger W. Ward, Robert B. Wiggins, Survey of Quartz Bulk Resonator Sensor Technologies, IEEE Transactions of Ultrasonics, Ferroelectrics, and Frequency Control, Vol. 35, No. 3, May, 1988</p> <p>R. Brendel, Influence of a Magnetic Field on Quartz Crystal Resonators IEEE Transactions on Ultrasonics, Ferroelectrics, and Frequency Control, Vol 43, No. 5, pp 818-831, September 1996</p> <p>Colin K. Campbell, Applications of Surface Acoustic and Shallow Bulk Acoustic Wave Devices, Proceedings of the IEEE, Vol. 77, No. 10, October 1989</p>	

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 03 of 10

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Application Number	10/618,282
Filing Date	July 9, 2003
First Named Inventor	Sorrells, Martin
Group Art Unit	
Examiner Name	
Attorney Docket Number	AES 03-002

OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T ²
		<p>George Kamas and Sandra Howe, Coordinated Universal Time (UTC) and Leap Second Time and Frequency Users Manual, NBS Special Publication 559, Chapter 2, Section 2.1, November 1979 (updated May 1997)</p> <p>W. J. Riley, The Calculation of Time Domain Frequency Stability - a revised version of these 2 papers: A Test Suite for the Calculation of Time Domain Frequency Stability, Proc. 1995 IEEE Freq. Contrl. Symp., pp. 360-366, June 1995 and Addendum to a Test Suite for the Calculation of Time Domain Frequency Stability, Proc. 1996 IEEE Freq. Contrl. Symp., pp. 880-882, June 1996.</p> <p>John R. Vig and Arthur Ballato, Frequency Control Devices, reprints from Ultasonic Instruments and Devices 1999, Academic Press, Inc. pp 637 - 701</p> <p>Errol P. EerNisse, Quartz Crystals vs. Their Environment: Time Bases or Sensors?: Tutorials, IEEE, Frequency Control Reference and Tutorial Information</p> <p>Fabien Josse and Richard W. Cernosek; Resonant Piezoelectric Devices as Physical and Biochemical Sensors; 2002 IEEE International Frequency Control Symposium Tutorials, New Orleans. June 1, 2002.</p> <p>Leonhard M. Reindl, Wireless Passive SAW Identification Marks and Sensors; A Tutorial 2002 IEEE International Frequency Control Symposium Tutorials, New Orleans, June 1, 2002.</p> <p>John R. Vig; Quartz Crystal Resonators and Oscillators; A Tutorial 2002 IEEE International Frequency Control Symposium Tutorials, New Orleans, June 1, 2002.</p> <p>Michael M. Driscoll; Low Noise Oscillator Design and Performance: A Tutorial 2002 IEEE International Frequency Control Symposium Tutorials, New Orleans, June 1, 2002.</p> <p>Jeremy K. Everard; The Fundamental Theory of Low Noise Oscillators with Special Reference to Some Detailed Designs; A Tutorial IEEE Frequency Control Symposium Tutorial, Kansas City, June 6th 2000</p> <p>Leonard S. Cutler; Passive Atomic Frequency Standards: A Tutorial 2002 IEEE International Frequency Control Symposium Tutorials, New Orleans, June 1, 2002.</p>	

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 04 of 10

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Application Number	10/618,282
Filing Date	July 9, 2003
First Named Inventor	Sorrells, Martin
Group Art Unit	
Examiner Name	
Attorney Docket Number	AES 03-002

OTHER PRIOR ART -- NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T ²
		<p>W. J. Riley; Rubidium Frequency Standard Technology: A Tutorial PTTI 2002 Tutorial, Reston, VA December 2, 2002</p> <p>Lute Maleki; Advanced Atomic Clocks; A Tutorial 2000 IEEE International Frequency Control Symposium Tutorials, Kansas City June 6, 2000</p> <p>X. Steve Yao; Photonic Techniques for Frequency and Timing: A Tutorial 2000 IEEE International Frequency Control Symposium Tutorials, Kansas City June 6, 2000</p> <p>G. John Dick; Sapphire Microwave Frequency Sources; A Tutorial 2002 IEEE International Frequency Control Symposium Tutorials, New Orleans, June 1, 2002.</p> <p>Eva S. Ferre-Pikal; PM and AM Noise Measurement Techniques - Part I: A Tutorial 2002 IEEE International Frequency Control Symposium Tutorials, New Orleans, June 1, 2002.</p> <p>Craig Nelson; PM & AM Noise II: A Tutorial 2002 IEEE International Frequency Control Symposium Tutorials, New Orleans, June 1, 2002.</p> <p>Victor S. Reinhardt; The Basics of Statistical Processes and Time and Frequency; A Tutorial. 2002 IEEE International Frequency Control Symposium Tutorials, New Orleans, June 1, 2002.</p> <p>Don Percival; An Introduction to the Wavelet Analysis of Time Series; A Tutorial 2000 IEEE International Frequency Control Symposium Tutorials, Kansas City June 6, 2000</p> <p>Venceslav F. Kroupa; Principles of Phase Locked Loops (PLL): A Tutorial 2000 IEEE International Frequency Control Symposium Tutorials, Kansas City June 6, 2000</p> <p>Bob Temple; Clock Jitter - Jitter Estimation from Frequency Domain Measurements: A Tutorial. 2000 IEEE International Frequency Control Symposium Tutorials, Kansas City June 6, 2000</p> <p>Thomas E. Parker; Introduction to Time and Frequency Transfer: A Tutorial 2002 IEEE International Frequency Control Symposium Tutorials, New Orleans, June 1, 2002.</p>	

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Sheet 05 of 10

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Application Number	10/618,282
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		<p>Samuel R. Stein; Digital Measurement of Precision Oscillators; A Tutorial IEEE, Frequency Control Reference and Tutorial Information website</p> <p>D.A. Howe, D.W. Allan, and J.A. Barnes; Properties of Oscillator Signals and Measurement Methods; A Tutorial. IEEE, Frequency Control Reference and Tutorial Information website.</p> <p>Jack Kusters; Fundamentals of X-Ray Orientation of Quartz Crystals; A Tutorial 2000 IEEE International Frequency Control Symposium Tutorials, Kansas City June 6, 2000</p> <p>Dan Russell; Acoustics and Vibration Animations; A Tutorial IEEE, Frequency Control Reference and Tutorial Information website</p> <p>Time and Frequency Division 847, National Institute of Standards and Technology; IEEE, Frequency Control Reference and Tutorial Information website</p> <p>Arthur Ballato; Transmission-Line Analogs for Piezoelectric Layered Structures: A Ph.D. Dissertations; IEEE, Frequency Control Reference and Tutorial Information website</p> <p>Angela M. Slocum; Basic Oscillators 101 - A Guide to Specifying Timing Devices: A Tutorial. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>Mike F. Wacker; Frequency Stability Characterization in the Time Domain: A Tutorial Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>Mike F. Wacker; OCXO Specification Guideline with "Cost Saver Tips": A Tutorial Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>David Chandler; Phase Jitter - Phase Noise and Voltage Controlled Crystal Oscillators: A Tutorial. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>David R. Shaner; Precision Frequency Measurment: A Tutorial Corning Frequency Control January 5, 1998: IEEE, Frequency Control Reference and Tutorial Information website</p>	

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Sheet 06 of 10

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		<p>Dan Nehring; Specifying OCXOs for Base Stations; A Tutorial Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>William P. Hanson and Timothy E Wickard; Acceleration Sensitivity as a Function of Temperature: A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>Lynn C. Heishman; Application Notes for Doubly Rotated Quartz Crystals: A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>Calibration of Time Base Oscillators; A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>Timothy E. Wickard and Willima P. Hanson; The Complication of Helium Desorption in the Helium Leak Method. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>Greg L. Weaver; The Use of a Computer Model to Determine the Complex Parametric Relationships of a Crystal Oscillator Circuit. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>James M. Griffith; Development and Advancements in SC-Cut Crystals. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website (first presented at the RF Expo EAST, 1994).</p> <p>Bruce R. Long; Frequency Correlation of Quartz Crystal Oscillators; A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website (first presented at the RF Expo East, 1990).</p> <p>T. Wickard, W.P. Hanson, G.P. Bal; A New Low Profile Coldweld Package. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website (first presented at the RF Expo East, 1990).</p> <p>G. Weaver, W/ Hanson & T. Wickard; A Insitu technique for the Resolution of Aging Contributions Between Quartz Resonators and Oscillator Circuits. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>W.P. Hanson, T.R. Meeker & L.C. Heishman; A New Factor Affecting the Acceleration Sensitivity of the Resonance Frequency of Quartz Crystal Resonators. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p>	

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		<p>N. Bates and G. Weaver; Phase Noise Frequency Distributions of SC and AT Quartz Crystal Resonators. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>G. Kurzenknabe; Practical Considerations in Specifications of High Stability Crystal Oscillators. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>W. Hanson; Probe Ion Signature in Quartz Electrodiffusion Data. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>B. Long; Quartz Crystals and Oscillators. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>B. Long and G. Weaver; Quartz Crystal Oscillators with Direct Resonator Heating. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>L. Heishman, A Review of Progress Related to Doubly Rotated Crystals. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>R. Zeigler, Jr.; Statistical Analysis of Allan Variance, Aging, Phase Noise, and Gravitational Sensitivity of Quartz Crystal Frequency Standards. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>G. Kurzenknabe; Vibrational Sensitivity and Phase Noise in Crystal Oscillators. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>V. Bottom; A History of the Quartz Crystal Industry in the USA. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>D. Chandler; A Statistical Analysis of Temperature Dependent Time Domain Phase Jitter. (MC061A1 series Bulk Acoustic Wave Quartz Crystal Oscillators). A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>C. Jensik, R. Zellers & R. Lackey; A Synopsis of Quality Involvement/Improvement Programs and the Ramifications on our Industry. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p>	

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 08 of 10

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Application Number	10/618,282
Filing Date	July 9, 2003
First Named Inventor	Sorrells, Martin
Group Art Unit	
Examiner Name	

Attorney Docket Number AES 03-002

OTHER PRIOR ART -- NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T ²
		<p>P. Brown; The Influence of Amateur Radio on the Development of the Commercial Market for Quartz Piezoelectric Resonators in the United States. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>H. Fanus; The Quartz Crystal Industry in Carlisle, PA. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>I. Albright; The Effect of Temperature on Crystal Oscillators. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>Branching out Through Band Width; Specialists in Successful Risk Analysis; and Promising Developments from a 'Virtual Drug Company'. Oak Industries Inc. featured on 'Business Now' at 9 AM Sunday, September 12, on WCVB-TV (www.batv.com).</p> <p>A Brief History of Corning Frequency Control. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>McCoy Electronics Photographs from the OFC Archives. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>McCoy Electronics Crystal Booklet (circa 1964) from the OFC Archives. A Technical Paper. Corning Frequency Control: IEEE, Frequency Control Reference and Tutorial Information website</p> <p>S. Cantor, A. Stern & B. Levy; Clock Technology. A Technical Paper. IEEE, Frequency Control Reference and Tutorial Information website</p> <p>Manish Vaish, A High Precision Quartz Oscillator with Performance Comparable to Rubidium Oscillators in Many Respects. A Technical Paper. 1996 IEEE Frequency Control Symposium Proceedings.</p> <p>John R. Vig; Quartz Crystal Resonators and Oscillators for Frequency Control and Timing Applications. A Tutorial. US Army Communications - Electronics Command, AMSEL-RD-C2-PT. January, 2001. Approved for public release. Distribution is unlimited.</p> <p>John R. Vig; Quartz Crystal Resonators and Oscillators for Frequency Control and Timing Applications. Product Catalog and Reference Materials. US Army Communications - Electronics Command. January, 2001. Approved for public release. Distribution is unlimited.</p>	

Examiner
Signature

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Sheet

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Group Art Unit	
Examiner Name	
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OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS

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		<p>I. Abramzom & R. Boroditsky; Thermodynamic Aspect of Short-Term Frequency Stability of Directly Heated Resonators. A Technical Paper. Valpey Fisher Corporation. Resource Center website.</p> <p>C. Serant; Celestica Net Income Soars 110%. Industrial Article from Daily News Digest. Valpey Fisher Corporation. Resource Center website.</p> <p>C. Souza; Chip Industry Still Expecting Growth in 2001. Industrial Article from Electronic Buyers' News. Valpey Fisher Corporation. Resource Center website.</p> <p>Reuters; Conexant to Supply Motorola Broadband Unit. Industrial Article from Daily News Digest. Valpey Fisher Corporation. Resource Center website.</p> <p>C. Souza; Component Avalanche Buries Suppliers. Industrial Article from Daily News Digest. Valpey Fisher Corporation. Resource Center website.</p> <p>R. Shim; Bluetooth Bite Blunted by MS Pullout. Industrial Article ZD Net News. Technology Summit October 8-9, 2003 Bloomberg Auditorium, London. Valpey Fisher Corporation website.</p> <p>Absolute Pull Range Note. Valpey Fisher Corporation website.</p> <p>Training Session - Electronics Applications of Quartz Xtal Oscillators. A Power Point presentation. Valpey Fisher Corporation. Resource Center website.</p> <p>Training Session - Crystal Environmental Specifications. A Power Point presentation. Valpey Fisher Corporation. Resource Center website.</p> <p>Training Session - Crystal Specifications. A Power Point presentation. Valpey Fisher Corporation. Resource Center website.</p> <p>Training Session - Frequency Tolerance. A Power Point presentation. Valpey Fisher Corporation. Resource Center website.</p>	

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STATEMENT BY APPLICANT**

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Sheet 10 of 10

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		Training Session - Quartz Crystal Work, An Intuitive Approach Part I and Part II. A Power Point presentation. Valpey Fisher Corporation. Resource Center website. Seriers QR High Precision Timebase/Reference Crystals and QT High Precision Temperature Sensor Crystals. A technical Paper; Quartzdyne Inc.,Quartzdyne, Inc. information website	

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